


<b>Search Notes</b> 	<b>Application/Control No.</b> 10580103	<b>Applicant(s)/Patent Under Reexamination</b> JEONG ET AL.
	<b>Examiner</b> DAVID CZEKAJ	<b>Art Unit</b> 2621

SEARCHED			
Class	Subclass	Date	Examiner
375	240.01-240.29	9/29/2010	DC

SEARCH NOTES		
Search Notes	Date	Examiner
East Search Attached	9/29/2010	DC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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